

TOSHIBA Field Effect Transistor Silicon P-Channel MOS Type (Ultra-High-Speed U-MOSIII)

# TPC8116-H

High Efficiency DC/DC Converter Applications  
 Notebook PC Applications  
 Portable Equipment Applications  
 CCFL Inverter Applications

- Small footprint due to a small and thin package
- High speed switching
- Small gate charge:  $Q_{SW} = 9.7 \text{ nC (typ.)}$
- Low drain-source ON-resistance:  $R_{DS(ON)} = 24\text{m}\Omega \text{ (typ.)}$
- High forward transfer admittance:  $|Y_{fs}| = 14 \text{ S (typ.)}$
- Low leakage current:  $I_{DSS} = -10 \mu\text{A (max)}$  ( $V_{DS} = -40 \text{ V}$ )
- Enhancement mode:  $V_{th} = -0.8 \text{ to } -2.0 \text{ V}$  ( $V_{DS} = -10 \text{ V}$ ,  $I_D = -1 \text{ mA}$ )

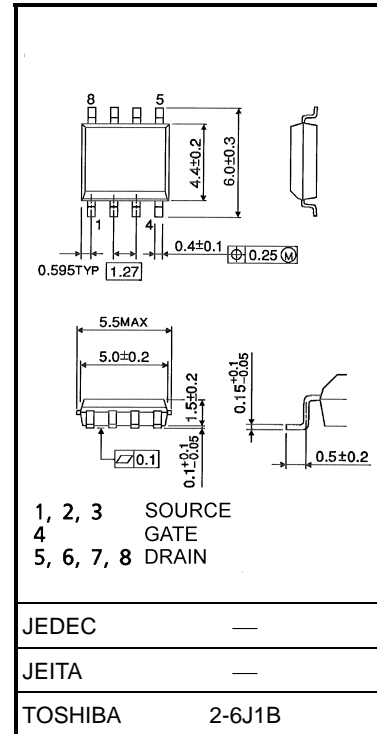
### Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

Characteristic		Symbol	Rating	Unit
Drain-source voltage		$V_{DSS}$	-40	V
Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )		$V_{DGR}$	-40	V
Gate-source voltage		$V_{GSS}$	$\pm 20$	V
Drain current	DC (Note 1)	$I_D$	-7.5	A
	Pulsed (Note 1)	$I_{DP}$	-30	
Drain power dissipation	( $t = 10 \text{ s}$ ) (Note 2a)	$P_D$	1.9	W
Drain power dissipation	( $t = 10 \text{ s}$ ) (Note 2b)	$P_D$	1.0	W
Single-pulse avalanche energy (Note 3)		$E_{AS}$	26	mJ
Avalanche current		$I_{AR}$	-7.5	A
Repetitive avalanche energy (Note 2a) (Note 4)		$E_{AR}$	0.12	mJ
Channel temperature		$T_{ch}$	150	$^\circ\text{C}$
Storage temperature range		$T_{stg}$	-55 to 150	$^\circ\text{C}$

Note: For Notes 1 to 4, refer to the next page.

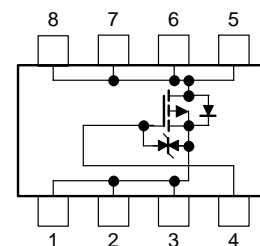
This transistor is an electrostatic-sensitive device. Handle with care.

Unit: mm



Weight: 0.085 g (typ.)

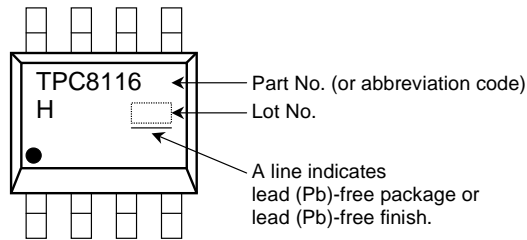
### Circuit Configuration



## Thermal Characteristics

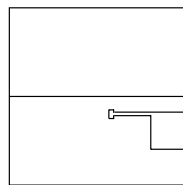
Characteristic	Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	$R_{th(ch-a)}$	65.8	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	$R_{th(ch-a)}$	125	°C/W

## Marking (Note 5)

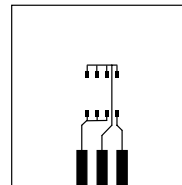


Note 1: The channel temperature should not exceed 150°C during use.

Note 2: (a) Device mounted on a glass-epoxy board (a) (b) Device mounted on a glass-epoxy board (b)



(a)



(b)

Note 3:  $V_{DD} = -24\text{ V}$ ,  $T_{ch} = 25^\circ\text{C}$  (initial),  $L = 0.5\text{ mH}$ ,  $R_G = 25\ \Omega$ ,  $I_{AR} = -7.5\text{ A}$

Note 4: Repetitive rating: pulse width limited by max channel temperature

Note 5: • on the lower left of the marking indicates Pin 1.

\* Weekly code: (Three digits)



Week of manufacture

(01 for first week of the year, continuing up to 52 or 53)

Year of manufacture

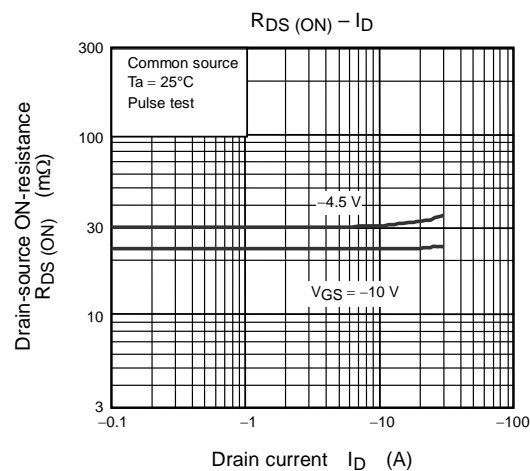
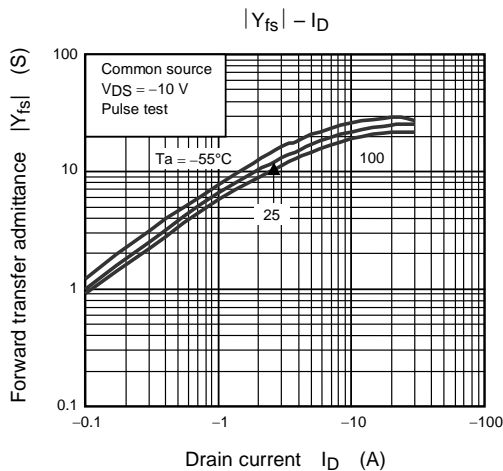
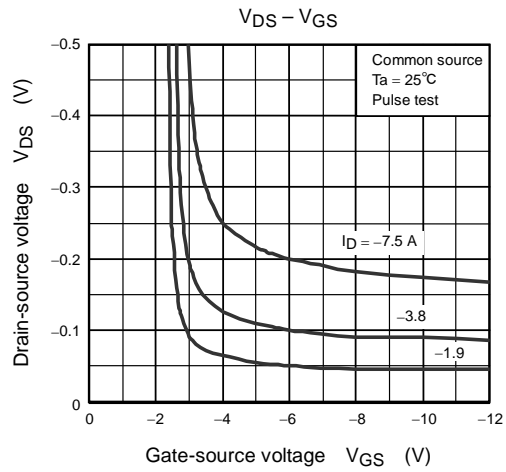
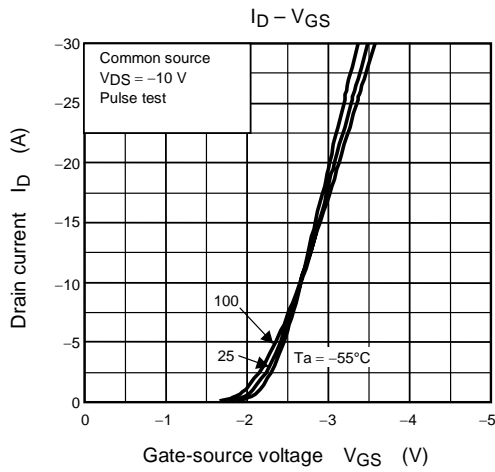
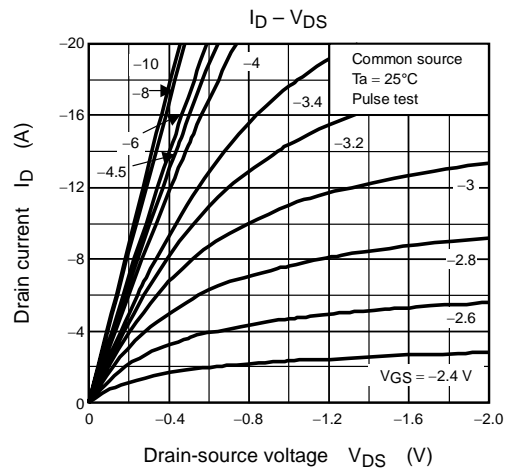
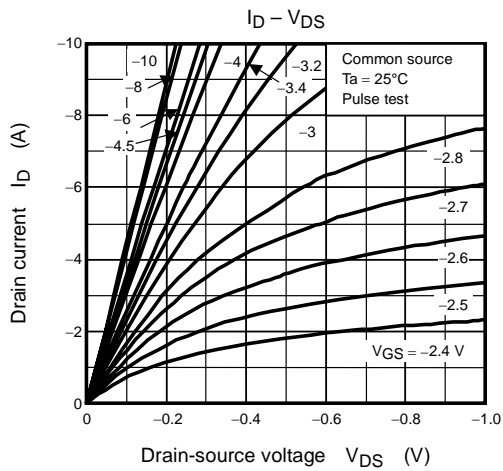
(The last digit of the calendar year)

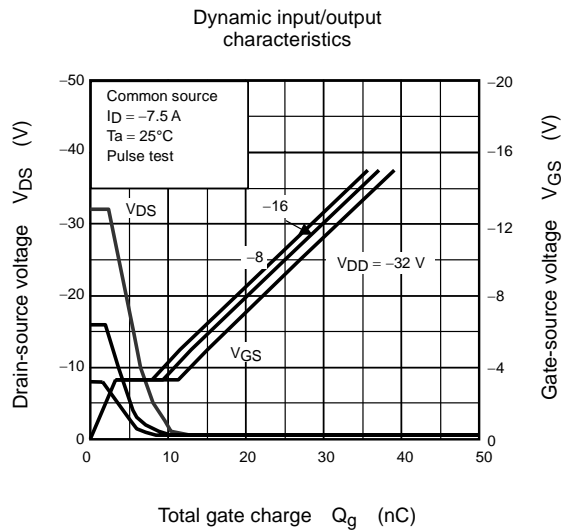
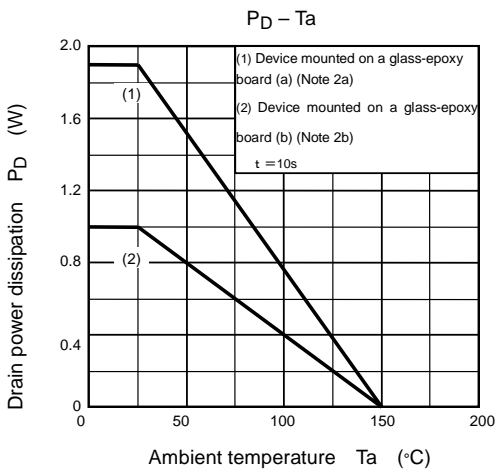
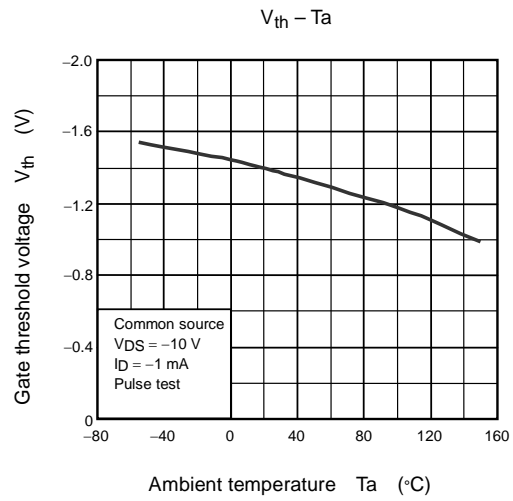
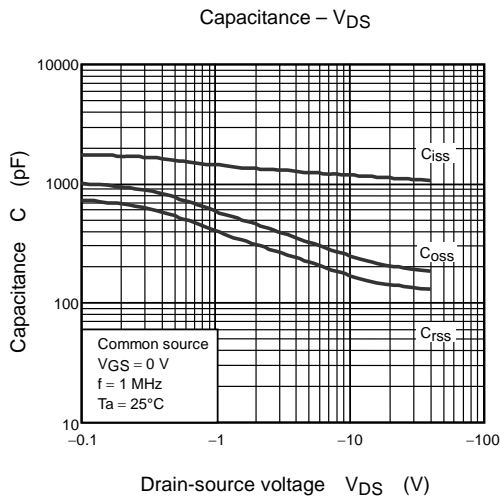
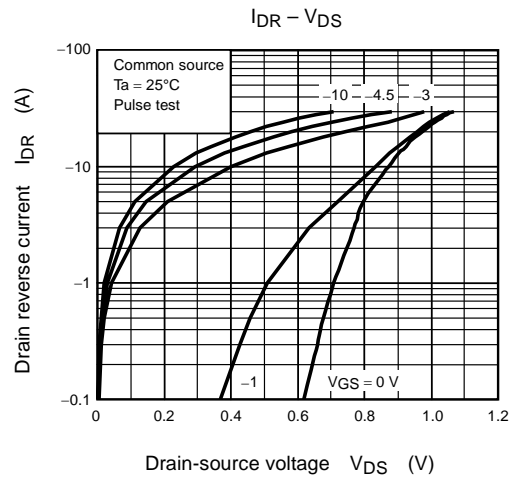
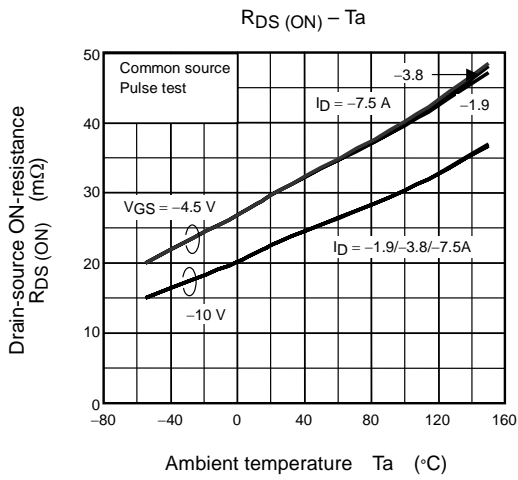
## Electrical Characteristics (Ta = 25°C)

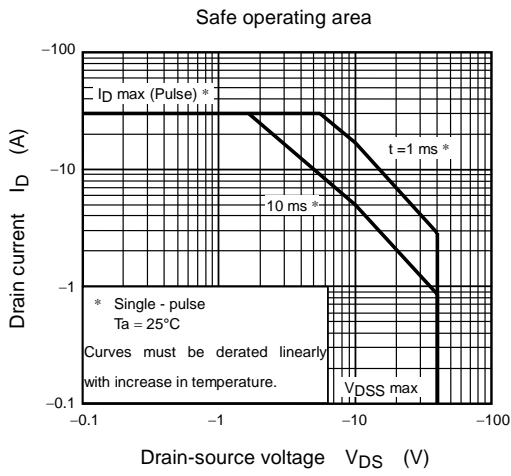
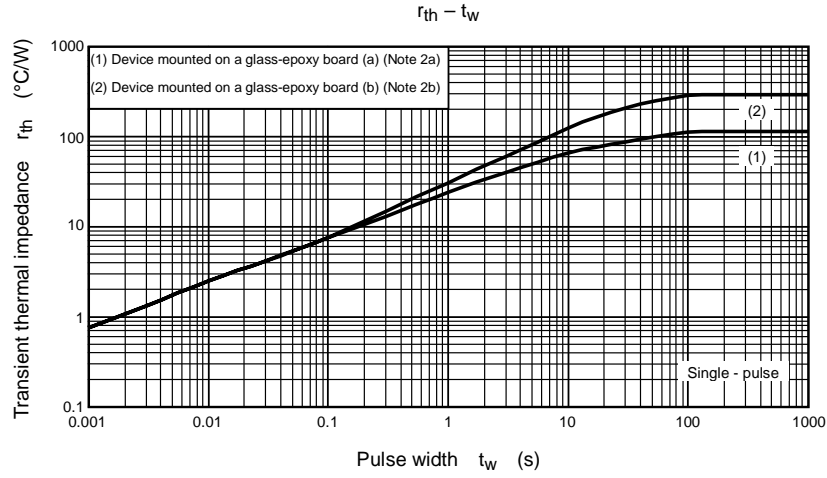
Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		$I_{GSS}$	$V_{GS} = \pm 16\text{ V}, V_{DS} = 0\text{ V}$	—	—	$\pm 10$	$\mu\text{A}$
Drain cutoff current		$I_{DSS}$	$V_{DS} = -40\text{ V}, V_{GS} = 0\text{ V}$	—	—	-10	$\mu\text{A}$
Drain-source breakdown voltage		$V_{(BR)DSS}$	$I_D = -10\text{ mA}, V_{GS} = 0\text{ V}$	-40	—	—	V
		$V_{(BR)DSX}$	$I_D = -10\text{ mA}, V_{GS} = 20\text{ V}$	-20	—	—	
Gate threshold voltage		$V_{th}$	$V_{DS} = -10\text{ V}, I_D = -1\text{ mA}$	-0.8	—	-2.0	V
Drain-source ON-resistance		$R_{DS(ON)}$	$V_{GS} = -4.5\text{ V}, I_D = -3.8\text{ A}$	—	29	37	$\text{m}\Omega$
			$V_{GS} = -10\text{ V}, I_D = -3.8\text{ A}$	—	24	30	
Forward transfer admittance		$ Y_{fs} $	$V_{DS} = -10\text{ V}, I_D = -3.8\text{ A}$	7	14	—	S
Input capacitance		$C_{iss}$	$V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	—	1190	—	pF
Reverse transfer capacitance		$C_{riss}$		—	170	—	
Output capacitance		$C_{oss}$		—	250	—	
Switching time	Rise time	$t_r$	<p><math>V_{GS} = 0\text{ V}</math> <math>-10\text{ V}</math> <math>I_D = -3.8\text{ A}</math> <math>V_{DD} \approx -20\text{ V}</math> <math>R_L = 5.3\Omega</math> <math>4.7\Omega</math> Duty <math>\leq 1\%</math>, <math>t_w = 10\ \mu\text{s}</math></p>	—	5	—	ns
	Turn-on time	$t_{on}$		—	12	—	
	Fall time	$t_f$		—	12	—	
	Turn-off time	$t_{off}$		—	43	—	
Total gate charge (gate-source plus gate-drain)		$Q_g$	$V_{DD} \approx -32\text{ V}, V_{GS} = -10\text{ V}, I_D = -7.5\text{ A}$	—	27	—	nC
			$V_{DD} \approx -32\text{ V}, V_{GS} = -5\text{ V}, I_D = -7.5\text{ A}$	—	15	—	
Gate-source charge 1		$Q_{gs1}$	$V_{DD} \approx -32\text{ V}, V_{GS} = -10\text{ V}, I_D = -7.5\text{ A}$	—	3.2	—	
Gate-drain ("Miller") charge		$Q_{gd}$		—	8.1	—	
Gate switch charge		$Q_{SW}$		—	9.7	—	

## Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
Drain reverse current	Pulse (Note 1)	$I_{DRP}$	—	—	—	-30	A
Forward voltage (diode)		$V_{DSF}$	$I_{DR} = -7.5\text{ A}, V_{GS} = 0\text{ V}$	—	—	1.2	V







**RESTRICTIONS ON PRODUCT USE**

060116EAA

- The information contained herein is subject to change without notice. 021023\_D
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.  
In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc. 021023\_A
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk. 021023\_B
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations. 060106\_Q
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of TOSHIBA or others. 021023\_C